### TOSHIBA PHOTOCOUPLER GaAs IRED & PHOTO-TRANSISTOR

# TLP283,TLP283-4

### PROGRAMMABLE CONTROLLERS

AC adapters for PDAs/ on-board power supplies I/O interface boards

TLP283 and TLP283-4 is a very small and thin coupler, suitable for surface mount assembly in applications such as on-board power supplies, programmable controllers.

TLP283 and TLP283-4 consist of photo transistor, optically coupled to a gallium arsenide infrared emitting diode.

Collector-Emitter Voltage : 100 V (MIN)

Current Transfer Ratio : 100% (MIN)@IF=1mA

• 1 Pulse delay time(Note 1) : 100us(MAX)@IF=1mA,RL=10kΩ

Isolation Voltage : 2500 Vrms (MIN)

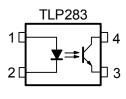
• UL Recognized : UL1577 , File No. E67349

Note 1: 1 Pulse delay time = tON+tOFF

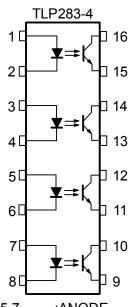
# Unit in mm TLP283 TLP283 TLP283 TLP283 TOSHIBA 11-3A1

Weight: 0.05 g (typ.)

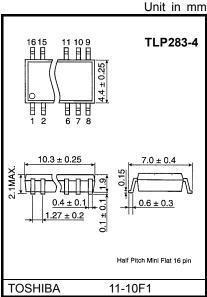
## Pin Configuration (Top view)



1:ANODE 2:CATHODE 3:EMITTER 4:COLLECTOR



1,3,5,7 :ANODE 2,4,6,8 :CATHODE 9,11,13,15 :EMITTER 10,12,14,16 :COLLECTOR



Weight: 0.19 g (typ.)



### Absolute Maximum Ratings (Ta = 25°C)

| CHARACTERISTIC  |  | SYMBOL              | RAT                    | UNIT           |        |
|---|--|---------------------|------------------------|----------------|--------|
|   | CHARACTERISTIC   | STIVIBOL            | TLP283                 | TLP283-4       | UNIT   |
|   | Forward Current  | lF                  | 50                     |                | mA     |
|   | Forward Current Derating                                     | ΔI <sub>F</sub> /°C | -0.7 (Ta≥53°C)         | -0.5 (Ta≥25°C) | mA /°C |
| LED   | Pulse Forward Current  | I <sub>FP</sub>     |                        | 1              | Α      |
|   | Reverse Voltage  | V <sub>R</sub>      |                        | V              |        |
|   | Junction Temperature   | Tj                  | 125                    |                | °C     |
|   | Collector-Emitter Voltage                                    | V <sub>CEO</sub>    | 10                     | V              |        |
|   | Emitter-Collector Voltage                                    | V <sub>ECO</sub>    | -                      | V              |        |
| R   | Collector Current  | IC                  | 50                     |                | mA     |
| DETECTOR  | Collector Power Dissipation (1 Circuit)                      | PC                  | 150                    | 100            | mW     |
| D   | Collector Power Dissipation<br>Derating(Ta≥25°C) (1 Circuit) | ΔP <sub>C</sub> /°C | -1.5                   | -1.0           | mW /°C |
|   | Junction Temperature   | Tj                  | 12                     | °C             |        |
| Оре   | erating Temperature Range                                    | T <sub>opr</sub>    | -55                    | °C             |        |
| Storage Temperature Range   |  | T <sub>stg</sub>    | -55                    | °C             |        |
| Lead Soldering Temperature  |  | T <sub>sol</sub>    | 260 (10s)              |                | °C     |
| Total Package Power Dissipation (1 Circuit)                       |  | P <sub>T</sub>      | 200                    | 170            | mW     |
| Total Package Power Dissipation<br>Derating (Ta≥25°C) (1 Circuit) |  | ΔP <sub>T</sub> /°C | -2.0                   | -1.7           | mW /°C |
| Isolation Voltage (Note2)   |  | BVS                 | 2500(AC,1min,R.H.≤60%) |                | Vrms   |

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

(Note2) Device considered a two terminal device: LED side pins shorted together and DETECTOR side pins shorted together.

### Individual Electrical Characteristics (Ta = 25°C)

|          | CHARACTERISTIC                         | SYMBOL                | TEST CONDITION   | MIN. | TYP.        | MAX.        | UNIT |
|----------|--|-----------------------|--|------|-------------|-------------|------|
|          | Forward Voltage                        | V <sub>F</sub>        | I <sub>F</sub> = 10 mA   | 1.0  | 1.15        | 1.3         | V    |
| LED      | Reverse Current                        | I <sub>R</sub>        | V <sub>R</sub> = 5 V   | _    | _           | 10          | μA   |
|          | Capacitance                            | C <sub>T</sub>        | V = 0, f = 1 MHz   | 1    | 30          | _           | pF   |
|          | Collector-Emitter<br>Breakdown Voltage | V <sub>(BR)</sub> CEO | I <sub>C</sub> = 0.5 mA  | 100  | _           | _           | ٧    |
| DETECTOR | Emitter-Collector<br>Breakdown Voltage | V <sub>(BR)</sub> ECO | I <sub>E</sub> = 0.1 mA  | 7    | _           | _           | ٧    |
|          | Collector Dark Current (Note3)         | lono                  | V <sub>CE</sub> = 48 V,<br>Ambient Light Below<br>(100 &x)           |      | 0.01<br>(2) | 0.1<br>(10) | μΑ   |
|          |  | ICEO                  | V <sub>CE</sub> = 48 V, Ta = 85°C<br>Ambient Light Below<br>(100 &x) | _    | 2<br>(4)    | 50<br>(50)  | μΑ   |
|          | Capacitance<br>(Collector to Emitter)  | C <sub>CE</sub>       | V = 0, f = 1 MHz   | _    | 10          | _           | pF   |

(Note3) Because of the construction,leak current might be increased by ambient light.

Please use photocoupler with less ambient light.

TLP283,TLP283-4

# Coupled Electrical Characteristics (Ta = 25°C)

| CHARACTERISTIC                          | SYMBOL                                | TEST CONDITION                                 | MIN. | TYP. | MAX. | UNIT |
|---|---------------------------------------|--|------|------|------|------|
| Current Transfer Ratio                  | I <sub>C</sub> / I <sub>F</sub>       | I <sub>F</sub> = 1 mA, V <sub>CE</sub> = 5 V   | 100  | _    | 400  | %    |
| Saturated CTR                           | I <sub>C</sub> / I <sub>F (sat)</sub> | IF = 1 mA, VCE = 0.4 V                         | 50   | _    | _    | %    |
| Collector-Emitter<br>Saturation Voltage | V <sub>CE</sub> (sat)                 | I <sub>C</sub> = 0.2 mA, I <sub>F</sub> = 1 mA | _    | 0.2  | 0.4  | V    |
| Off-State Collector Current             | I <sub>C (off)</sub>                  | V <sub>F</sub> = 0.7 V, V <sub>CE</sub> = 48 V | _    | _    | 10   | μA   |

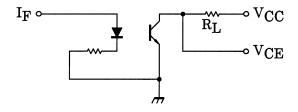
# Isolation Characteristics (Ta = 25°C)

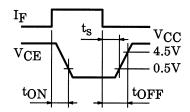
| CHARACTERISTIC                   | SYMBOL         | TEST CONDITION                   | MIN.               | TYP.             | MAX. | UNIT |
|----------------------------------|----------------|----------------------------------|--------------------|------------------|------|------|
| Capacitance<br>(Input to Output) | CS             | V <sub>S</sub> = 0 V, f = 1 MHz  | _                  | 8.0              | _    | pF   |
| Isolation Resistance             | R <sub>S</sub> | V <sub>S</sub> = 500 V, R.H.≤60% | 5×10 <sup>10</sup> | 10 <sup>14</sup> | _    | Ω    |
|                                  | BVS            | AC , 1 minute                    | 2500               | _                | _    | Vrms |
| Isolation Voltage                |                | AC , 1 second,in OIL             | _                  | 5000             | _    |      |
|                                  |                | DC , 1 minute, in OIL            | _                  | 5000             | _    | Vdc  |

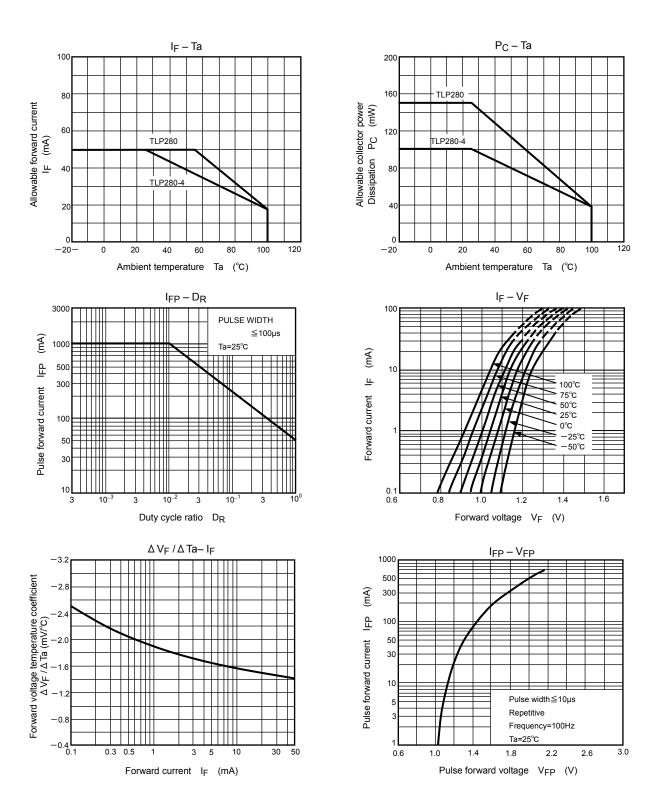
# **Switching Characteristics (Ta = 25°C)**

| CHARACTERISTIC     | SYMBOL          | TEST CONDITION   | MIN. | TYP. | MAX. | UNIT |
|--------------------|-----------------|--|------|------|------|------|
| Turn-On Time       | t <sub>ON</sub> | $V_{CC}$ = 5 V, IF = 1 mA<br>R <sub>L</sub> = 10k $\Omega$ | _    | 7.5  | 20   |      |
| Turn-Off Time      | toff            |  | _    | 70   | 90   | μs   |
| 1 Pulse delay time | ton+ toff       |  | _    | 80   | 100  |      |

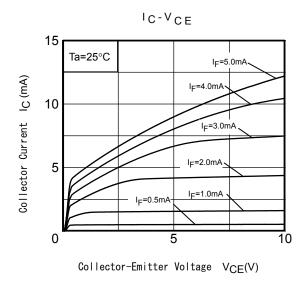
(Fig.1)SWITCHING TIME TEST CIRCUIT

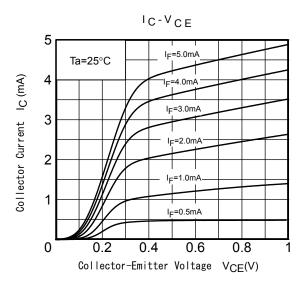


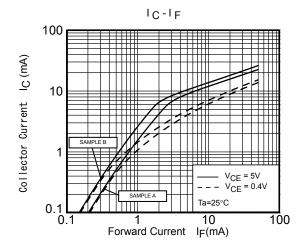


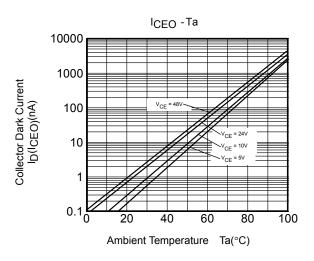


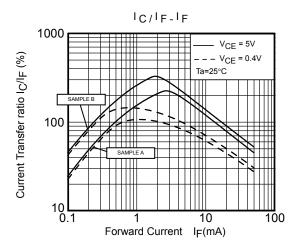
<sup>\*:</sup> The above graphs show typical characteristics.



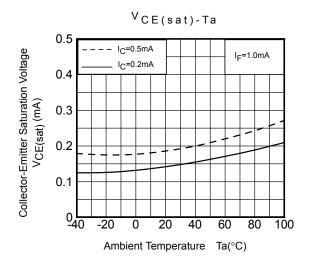


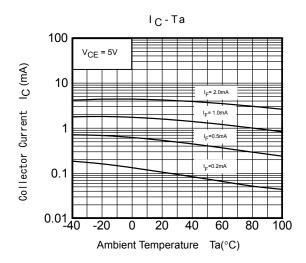


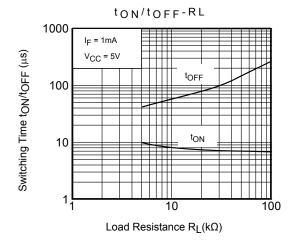


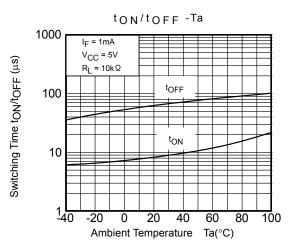


<sup>\*:</sup> The above graphs show typical characteristics.









<sup>\*:</sup> The above graphs show typical characteristics.

### RESTRICTIONS ON PRODUCT USE

20070701-EN

- The information contained herein is subject to change without notice.
- TOSHIBA is continually working to improve the quality and reliability of its products. Nevertheless, semiconductor devices in general can malfunction or fail due to their inherent electrical sensitivity and vulnerability to physical stress. It is the responsibility of the buyer, when utilizing TOSHIBA products, to comply with the standards of safety in making a safe design for the entire system, and to avoid situations in which a malfunction or failure of such TOSHIBA products could cause loss of human life, bodily injury or damage to property.
  In developing your designs, please ensure that TOSHIBA products are used within specified operating ranges as set forth in the most recent TOSHIBA products specifications. Also, please keep in mind the precautions and conditions set forth in the "Handling Guide for Semiconductor Devices," or "TOSHIBA Semiconductor Reliability Handbook" etc.
- The TOSHIBA products listed in this document are intended for usage in general electronics applications (computer, personal equipment, office equipment, measuring equipment, industrial robotics, domestic appliances, etc.). These TOSHIBA products are neither intended nor warranted for usage in equipment that requires extraordinarily high quality and/or reliability or a malfunction or failure of which may cause loss of human life or bodily injury ("Unintended Usage"). Unintended Usage include atomic energy control instruments, airplane or spaceship instruments, transportation instruments, traffic signal instruments, combustion control instruments, medical instruments, all types of safety devices, etc.. Unintended Usage of TOSHIBA products listed in his document shall be made at the customer's own risk.
- The products described in this document shall not be used or embedded to any downstream products of which manufacture, use and/or sale are prohibited under any applicable laws and regulations.
- The information contained herein is presented only as a guide for the applications of our products. No
  responsibility is assumed by TOSHIBA for any infringements of patents or other rights of the third parties which
  may result from its use. No license is granted by implication or otherwise under any patents or other rights of
  TOSHIBA or the third parties.
- GaAs(Gallium Arsenide) is used in this product. The dust or vapor is harmful to the human body. Do not break, cut, crush or dissolve chemically.
- Please contact your sales representative for product-by-product details in this document regarding RoHS
  compatibility. Please use these products in this document in compliance with all applicable laws and regulations
  that regulate the inclusion or use of controlled substances. Toshiba assumes no liability for damage or losses
  occurring as a result of noncompliance with applicable laws and regulations.